

<b>Notice of References Cited</b>	Application/Control No. 10/630,787	Applicant(s)/Patent Under Reexamination KEE ET AL.	
	Examiner Gregory M. Desire	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-RE36,041	01-1999	Turk et al.	382/118
*	B	US-2003/0007669	01-2003	Martinez, Aleix M.	382/118
*	C	US-2004/0034611	02-2004	Kee et al.	706/20
*	D	US-2004/0091137	05-2004	Yoon et al.	382/118
*	E	US-2004/0213454	10-2004	Lai et al.	382/159
*	F	US-2005/0147292	07-2005	Huang et al.	382/159
*	G	US-6,920,231	07-2005	Griffin, Paul A	382/118
*	H	US-7,035,456	04-2006	Lestideau, Fabrice	382/164
*	I	US-7,050,607	05-2006	Li et al.	382/118
*	J	US-7,164,781	01-2007	Kim et al.	382/118
*	K	US-7,187,786	03-2007	Kee, Seok-cheol	382/118
*	L	US-7,203,346	04-2007	Kim et al.	382/118
*	M	US-7,218,759	05-2007	Ho et al.	382/118

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.